NEC

SILICON TRANSISTOR
2SA1385-Z

PNP SILICON EPITAXIAL TRANSISTOR
MP-3

DESCRIPTION

2SA1385-Z is designed for Audio Frequency Amplifier and Switching, especially in Hybrid Integrated Circuits.

FEATURES

- Low $V_{CE(sat)}$: $V_{CE(sat)}$ = –0.18 V TYP.
- Complement to 2SC3518-Z

QUALITY GRADE

Standard

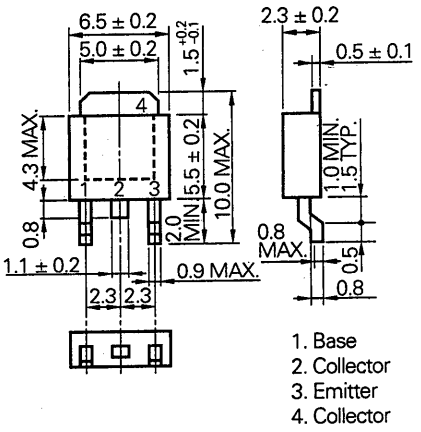
Please refer to "Quality grade on NEC Semiconductor Devices" (Document number IEI-1209) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

ABSOLUTE MAXIMUM RATINGS (T_a = 25 °C)

Collector to Base Voltage	V_{CBO}	–60	V
Collector to Emitter Voltage	V_{CEO}	–60	V
Emitter to Base Voltage	V_{EBO}	–7	V
Collector Current (DC)	I_C	–5	A
Collector Current (Pulse)*	I_C	–7	A
Total Power Dissipation (T_C = 25 °C)	P_T	10	W
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	–55 to +150	°C

* PW ≦ 10 ms, Duty Cycle ≦ 50 %

PACKAGE DIMENSIONS
(in millimeters)



1. Base
2. Collector
3. Emitter
4. Collector

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ELECTRICAL CHARACTERISTICS (T_a = 25 °C)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Collector Cutoff Current	I_{CBO}			−10	μA	V_{CB} = −50 V, I_E = 0
Emitter Cutoff Current	I_{EBO}			−10	μA	V_{EB} = −7.0 V, I_C = 0
DC Current Gain	h_{FE1}*	100	200	400		V_{CE} = −1.0 V, I_C = −2.0 A
DC Current Gain	h_{FE2}*	50	100			V_{CE} = −1.0 V, I_C = −5.0 A
Collector Saturation Voltage	$V_{CE(sat)}$*		−0.18	−0.3	V	I_C = −2.0 A, I_B = −0.2 A
Base Saturation Voltage	$V_{BE(sat)}$*			−1.2	V	I_C = −2.0 A, I_B = −0.2 A
Gain Bandwidth Product	f_T		140		MHz	V_{CE} = −10 V, I_C = −0.5 A
Turn-on Time	t_{on}		0.08	1.0	μs	I_C = −2.0 A, V_{CC} ≒ −10 V R_L = 50 Ω I_{B1} = −I_{B2} = −0.2 A
Storage Time	t_{stg}		0.55	2.5	μs	
Fall time	t_f		0.18	1.0	μs	

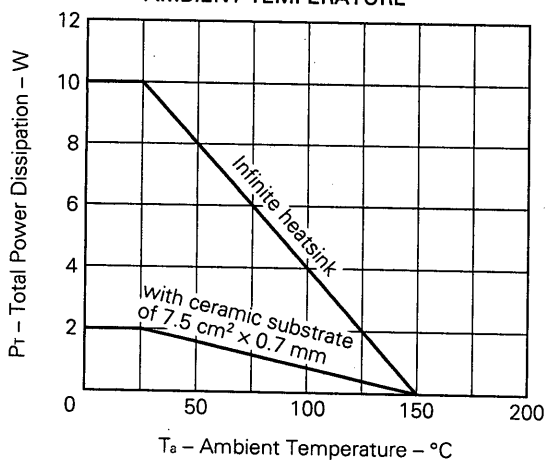
* Pulsed: PW ≦ 350 μs, Duty Cycle ≦ 2 %

h_{FE} Classification

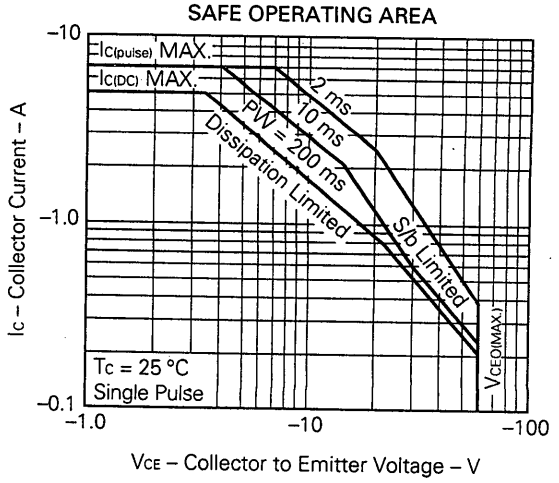
MARKING	M	L	K
h_{FE1}	100 to 200	160 to 320	200 to 400

TYPICAL CHARACTERISTICS (T_a = 25 °C)

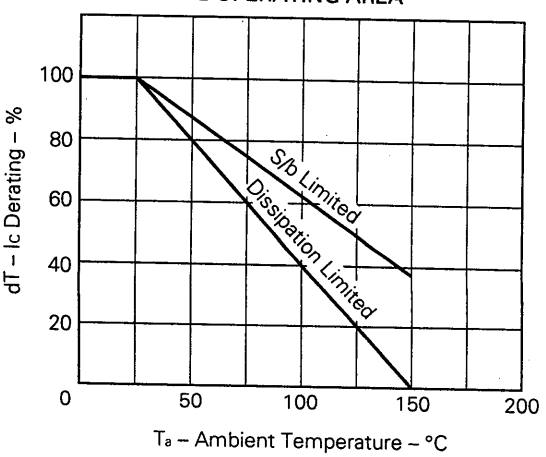
TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE



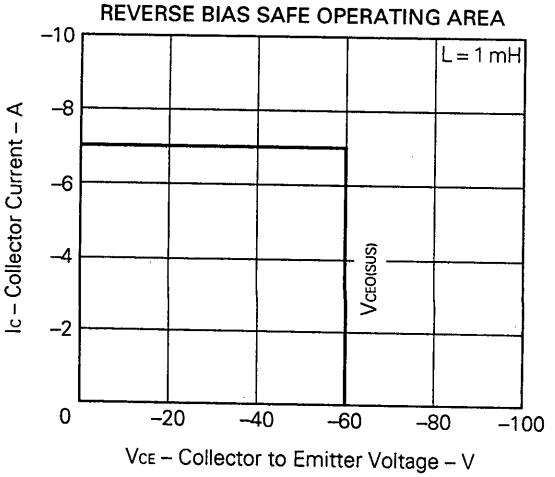
SAFE OPERATING AREA



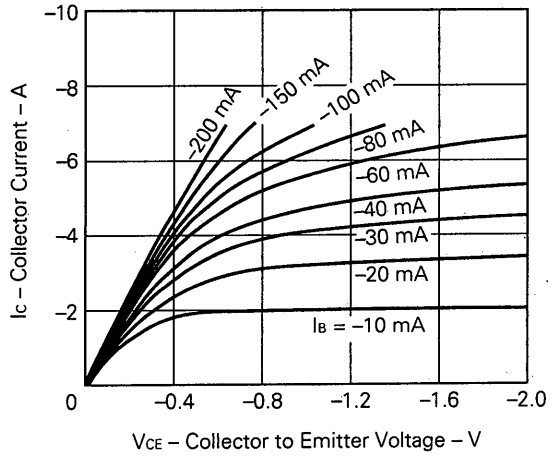
DERATING CURVE OF SAFE OPERATING AREA



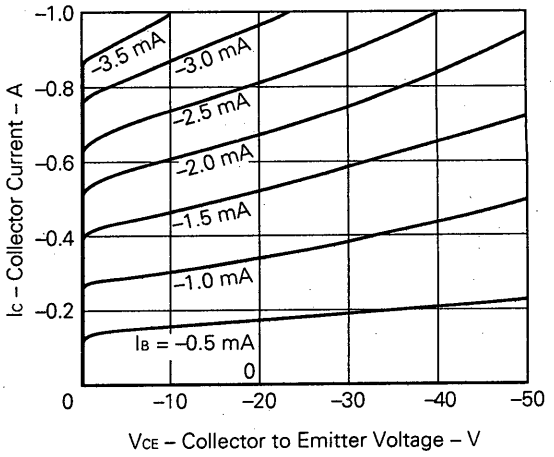
REVERSE BIAS SAFE OPERATING AREA



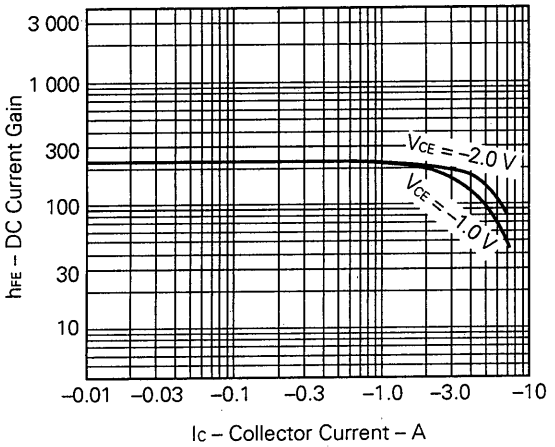
COLLECTOR CURRENT vs. COLLECTOR TO EMITTER VOLTAGE



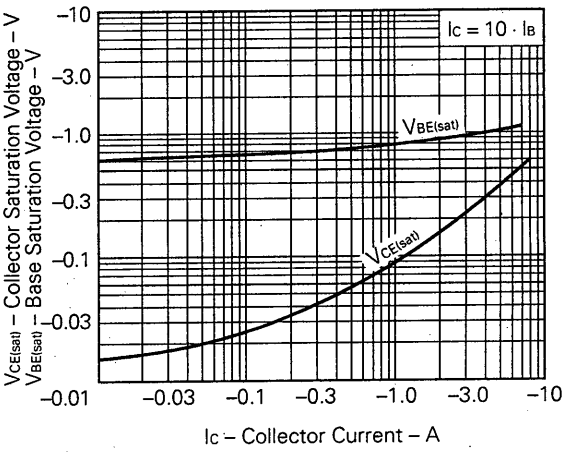
COLLECTOR CURRENT vs. COLLECTOR TO EMITTER VOLTAGE



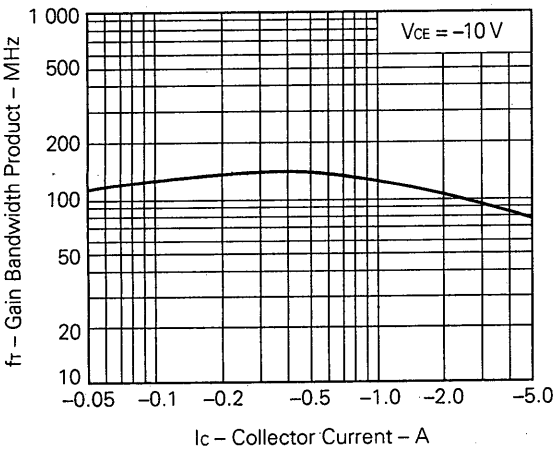
DC CURRENT GAIN vs. COLLECTOR CURRENT



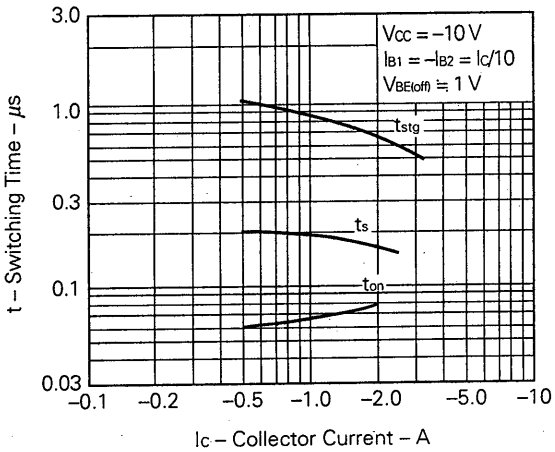
COLLECTOR AND BASE SATURATION VOLTAGE vs. COLLECTOR CURRENT



GAIN BANDWIDTH PRODUCT vs. COLLECTOR CURRENT



SWITCHING TIME vs. COLLECTOR CURRENT



Reference

Application note name	No.
Quality control of NEC semiconductors devices.	TEI-1202
Quality control guide of semiconductors devices.	MEI-1202
Assembly manual of semiconductors devices.	IEI-1207
Design of Push-Pull Type Switching Regulators (Basic).	TEB-1002
Design of Push-Pull Type Switching Regulators (Applications).	TEB-1003
Optimum Base Drive Conditions of Switching Power Transistors.	TEB-1014

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